

# ST13003

## HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- MEDIUM VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

#### **APPLICATIONS:**

- ELECTRONIC BALLASTS FOR
  FLUORESCENT LIGHTING
- SWITCH MODE POWER SUPPLIES

#### DESCRIPTION

The device is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and medium voltage capability.

It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The device is designed for use in lighting applications and low cost switch-mode power supplies.





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
VCES	Collector-Emitter Voltage (V <sub>BE</sub> = 0)	700	V
Vceo	Collector-Emitter Voltage $(I_B = 0)$	400	V
V <sub>EBO</sub>	Emitter-Base Voltage ( $I_c = 0$ , $I_B = 0.75$ A, $t_p < 10\mu$ s, $T_j < 150^{\circ}$ C)	BV <sub>EBO</sub>	V
lc	Collector Current	1.5	A
Ісм	Collector Peak Current (t <sub>p</sub> < 5 ms)	3	А
lв	Base Current	0.75	A
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5 ms)	1.5	А
Ptot	Total Dissipation at $T_c = 25$ °C	40	W
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C

#### THERMAL DATA

R <sub>thj-case</sub>	Thermal	Resistance	Junction-case	Max	3.12	°C/W
$R_{thj-amb}$	Thermal	Resistance	Junction-ambient	Max	89	°C/W

### **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25 \ ^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Test Cor	nditions	Min.	Тур.	Max.	Unit
I <sub>CEV</sub>	Collector Cut-off Current ( $V_{BE} = -1.5V$ )	V <sub>CE</sub> = 700V V <sub>CE</sub> = 700V	$T_j = 125^{\circ}C$			1 5	mA mA
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage (I <sub>C</sub> = 0)	I <sub>E</sub> = 10 mA		9		18	V
V <sub>CEO(sus)</sub> *	Collector-Emitter Sustaining Voltage $(I_B = 0)$	I <sub>C</sub> = 10 mA L = 25mH		400			V
V <sub>CE(sat)</sub> *	Collector-Emitter Saturation Voltage	$I_{C} = 0.5 A$ $I_{C} = 1 A$ $I_{C} = 1.5 A$	$I_{B} = 0.1 A$ $I_{B} = 0.25 A$ $I_{B} = 0.5 A$			0.5 1 3	V V V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	$I_{C} = 0.5 A$ $I_{C} = 1 A$	$I_{\rm B} = 0.1 \text{ A}$ $I_{\rm B} = 0.25 \text{ A}$			1.0 1.2	V V
h <sub>FE</sub>	DC Current Gain	I <sub>C</sub> = 0.5 A Group A Group B I <sub>C</sub> = 1 A	V <sub>CE</sub> = 2 V V <sub>CE</sub> = 2 V	8 15 5		20 35 25	
tr t <sub>s</sub> t <sub>f</sub>	RESISTIVE LOAD Rise Time Storage Time Fall Time	Ic = 1 A I <sub>B1</sub> = 0.2 A T <sub>p</sub> = 25 μs	V <sub>CC</sub> = 125 V I <sub>B2</sub> = -0.2 A			1.0 4.0 0.7	μs μs μs
ts	INDUCTIVE LOAD Storage Time	$I_{C} = 1 A$ $V_{BE} = -5 V$ $V_{clamp} = 300 V$	I <sub>B1</sub> = 0.2 A L = 50 mH		0.8		μs

\* Pulsed: Pulse duration = 300µs, duty cycle = 1.5 % Note : Product is pre-selected in DC current gain (GROUP A and GROUP B). STMicroelectronics reserves the right to ship either groups according to production availability. Please contact your nearest STMicroelectronics sales office for delivery details.

#### Safe Operating Areas



DC Current Gain



Collector Emitter Saturation Voltage



**Derating Curve** 











#### Inductive Fall Time



**Reverse Biased SOA** 



Inductive Storage Time



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#### Figure 1: Inductive Load Switching Test Circuits.



Figure 2: Resistive Load Switching Test Circuits.



DIM.	mm			inch			
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	7.4		7.8	0.291		0.307	
В	10.5		10.8	0.413		0.445	
b	0.7		0.9	0.028		0.035	
b1	0.49		0.75	0.019		0.030	
С	2.4		2.7	0.040		0.106	
c1	1.0		1.3	0.039		0.050	
D	15.4		16.0	0.606		0.629	
е		2.2			0.087		
e3	4.15		4.65	0.163		0.183	
F		3.8			0.150		
G	3		3.2	0.118		0.126	
Н			2.54			0.100	





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